

SAS-2 S-Parameters of Cable Assemblies and Backplanes (08-187r1)

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Assertion



- The common mode return loss S_{CC22} and differential to common mode return loss S_{CD22} proposed in the SAS-2 letter ballot do appear to be attainable using existing SAS connector designs.
- In addition, common layout practices and techniques used to reduce electromagnetic emissions conflict with the proposed S_{CC22} limits.

SAS-2 Letter Ballot Specifications





Cable Assembly Data





Cable Assembly Data Notes



- Samples consisting of three cable lengths from three different suppliers were measured
- Fixturing was not de-embedded but the test board traces maintained a well controlled 25-ohm common mode impedance up to the miniSAS connector footprint
- The miniSAS connector/cable interface has at least three unique coupled regions with each one yielding a unique common mode impedance ... PBC mounted connector, paddle card and bulk cable

Common Mode Impedance Variations in Board Design

- Trace structure variation is a common layout practice
- Trace with and spacing are varied in order to access all points in connector and BGA pinfields
- Differential impedance is maintained while common mode impedance variations are tolerated



Component Pinfield



Trace Structure Simulations



- To better characterize the effects of such layout practices, three separate designs are simulated.
 - One inch uncoupled microstrip + one inch 100-ohm differential coupled microstrip with a single ended impedance of 54-ohms + 50ohm termination for each leg
 - One inch uncoupled microstrip + one inch 100-ohm differential coupled microstrip with a single ended impedance of 70-ohms + 50ohm termination for each leg
 - One inch uncoupled microstrip + one inch 100-ohm differential coupled microstrip with a single ended impedance of 80-ohms + 50ohm termination for each leg
- The model is driven by a common mode source and then converted to $\rm S_{\rm CC22}$ format.

Trace Structure Simulations





Zincident

Reflection Coefficient (•) and S₂₂

- The reflection coefficient (•) is the ratio of the amplitudes of the reflected wave to the incident wave
- It can be computed from the impedances of the incident media and termination
- For the case of a common mode impedance of 40ohms we obtain,

$$\rho = 0.23 \&$$

S_{CC22} = -12.7dB

$$\Gamma = \frac{V_{reflected}}{V_{incident}} = \frac{Z_t - Z_i}{Z_t + Z_i}$$

S22 = 20log(Γ)
Incident Wave
Reflected Wave





Multiple Impedance Discontinuities



 Each change in common mode impedance will introduce a wave back to the compliance point. Multiple changes between 25 and 40 ohms will result in a return loss greater than -12.7dB at specific frequency points



Potential Scd22 Issues



- Imperfect twin-axial cable termination is very common. Any imbalance introduced during the assembly process can result in non-ideal mode conversion parameters (all S_{CD} and S_{DC} terms).





Conclusions



- The S_{CC22} data presented indicates letter ballot specification will be difficult to meet.
- However, the S_{CD22} cable assembly data supports the letter ballot specification numbers.

Discussion



- After discussion of the herein, the group agreed to removal of the S_{CC22} row from table 51.
- Additionally, the point was made that references made in table 51 to figures 125 and 126 of the transmitter section may be confusing the reader. The group decided to redirect those references to one or more new figures of S_{DD22}, S_{CD22}, S_{CD21} located right after table 51.

Recommended Editorial Changes



5.2.7 cable assembly and backplane S-parameters

S-parameters limits shall be calculated per the following formula. Variables are illustrated in figure 97 and specified in table 61

Measured value < max [L, min [H, N + 13.3 log₁₀(f / 3 GHz)]]

where:

S	is the slope in dB/decade
н	is the maximum value (i.e., the high frequency asymptote)
N	is the value at the Nyquist frequency (i.e., 3 GHz)
L	is the minimum value (i.e., the low frequency asymptote)
f	is the frequency of the signal in Hz
max [A, B]	is the maximum of A and B
min [A, B]	is the minimum of A and B

Add section 5.2.7





Figure 97 shows the S-parameter values.



L is the minimum value at the low frequency asymptote N is the value at the Nyquist frequency (i.e., 3 GHz) H is the maximum value at the high frequency asymptote S is the slope in dB/decade

Figure 97 - S-parameter values

Add figure 97 to section 5.2.7





Characteristic ^{a b c}	Reference	L (dB)	N (dB)	H (dB)	S (dB / decade)	f _{min} (MHz)	f _{max} (GHz)
S _{CC22}	Figure 127	VE	-5.0	0	13.3	100	6.0
S _{DD22}	Figure 127	-10	-7.9	0	13.3	100	6.0
S _{CD22}	Figure 128 (ecc 5.3.6.5.2)	-26	-12.7	-10	13.3	100	6.0
S _{CD21}	Figure 28	-24	-24	-24	0	100	6.0
Maximum near-end crosstalk (NEXT) for each receive signal pair ^e	97	-26	-26	-26	0	100	6.0
 connection. d See figure 127 in 5.3.6.5.2 e Determine all valid aggress range of this measurement frequency domain, of all crocrosstalk sources with mag The following equation deta TotalNEXT(f) = 10 × where: f frequency n umber of the near All NEXT values expressed meanitude 	for definitions of L, sor/victim near-end , determine the sum postalk transfer mod nitudes less than -5 ails the summation $\log \sum_{1}^{n} 10^{(\text{NEXT}(f)/2)}$ 1	N, H, S, fm crosstalk tr n of the cro des. To ren 50 dB (e.g. process of 10) rce	nin, and f _{ma} ransfer mo posstalk tran nove unwa , -60 dB) a the valid n	ix- des. Ove isfer ratio inted bias it all frequ iear-end	er the comp is, measure is due to tes uencies ma crosstalk se have negat	lete freq ed in the t fixture y be igno burces:	uency noise, ored.

Table 51 — Maximum limits for S-parameters of cable assemblies and backplanes

Modify table 51 and move to section 5.2.7

Recommended Editorial Changes





Figure 98 — cable assembly and backplane S_{DD22} , S_{CD21} and S_{CD22} limits.

Add figure 98 to section 5.2.7

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